003117 USA/ETCH/SILICON/JB1 APPL. NO. 00/545,110 Page 2 of 4

#### REMARKS

# Status of the Claims

Claims 1, 7-9, 13-16, 18, 20-28, 30-37, 78-90, and 102-108 are pending in the instant application, of which claims 1, 8, 13, 15, 18, 22, 78, 83, 88, and 102 were amended in the Amendment filed on April 17, 2003 (hereinafter referred to as "the Previous Amendment").

The claim amendments are fully supported by the original claims and the Specification, and entry of the claim amendments is respectfully requested. For example, claims 1, 8, 13, 15, 18, 22, 78, 83, 88, and 102 were amended to clarify the term "dynamic variance"; these amendments are supported at page 11, line 8 to page 12, line 32, of the Specification as well as Figures 2 and 3. Reconsideration of the present application in view of the Previous Amendment and the remarks herein is respectfully requested.

## Alleged Issue of New Matter

The Examiner alleges that the amendments to claims 1, 8, 13, 15, 18, 22, 78, 83, 88, and 102 that were made in the Previous Amendment raise the issue of new matter. For example, the Examiner alleges that "[t]he cited support on page 11, line 8, to page 12, line 32 was reviewed for support, but no discussion of calculating dynamic variance by subtracting minimum and maximum point intensities within a predetermined time was found."

However, a controller adapted to "calculate a dynamic variance within a predefined time period of the signal by subtracting an intensity value at a minimum point from an intensity value at a maximum point" does not raise an issue of new matter. Additionally, a method comprising "calculating a dynamic variance within a

003117 USA/ETCH/SILICON/JB1 APPL. NO. 09/515,110 Page 3 of 4

matter. Additionally, a method comprising "calculating a dynamic variance within a predefined time period of the signal by subtracting an intensity value at a minimum point from an intensity value at a maximum point" does not raise an issue of new matter.

Claim 79, as pending <u>before</u> the Previous Amendment, recites that "the controller is adapted to evaluate the dynamic variance ..." Therefore, the limitation of calculating a dynamic variance was present in the claims before the Previous Amendment. Furthermore, the Specification at page 11, lines 25-28, defines "dynamic variance" as "the change in amplitude over a predefined time period of the amplitude trace, for example, the amplitude change  $a_1$  in the trace labeled 208 [of Figure 2]." The referenced example " $a_1$ " of trace 208 of Figure 2, shows that the change in amplitude is the extent of change of the signal intensity over that predefined time period. The cut-off point on the left side of the trace is the beginning of a "predefined time period," and the cut-off point on the right side of the trace is the end of a "predefined time period," where the horizontal axis represents time. The value of " $a_1$ " is indicated by arrows that extend from a minimum point to a maximum point of the intensity signal over this predefined time period. Therefore, the extent of change of the signal intensity,  $a_1$ , is synonymous with the subtraction of the "intensity value at a minimum point" from the "intensity value at a maximum point" within that predefined time period.

Thus, these amendments do not raise the issue of new matter.

### Indication that Rejections are Overcome

Applicant appreciates the Examiner's indication that "the art rejections over Jamestowne Silver Polish would be overcome by these amendments [in the Previous Amendment], so would those over Busta et al., Christol et al., Schoenborn for claims proposed with the 'calculate' limitation."

003117 USA/ETCH/SILICON/JB1 APPL. NO. 09/545,110 Page 4 of 4

## CONCLUSION

For the foregoing reasons, allowance of the instant application is respectfully requested. Should the Examiner have any questions regarding the above amendments or remarks, the Examiner is requested to telephone Applicant's representative at the number listed below.

Respectfully submitted,

JANAH & ASSOCIATES, P.C.

Date: June 13, 2003

By:

Reece Nienstadt

Reg. No. 52,072

Please direct telephone calls to:

Reece Nienstadt (415) 538-1555

Please continue to send all correspondence to:

APPLIED MATERIALS, INC. Patent Department, M/S 2061 P.O. Box 450A Santa Clara, California 95052